Application/Control No. Applicant(s)/Patent Under Reexamination 10/653,176 LEE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Philip H Leung 3742 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY Devlin, John C. US-5,126,536 06-1992 219/497 Α US-В US-С D US-US-Ε

FOREIGN PATENT DOCUMENTS

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